Notice of References Cited Application/Control No. O9/475,135 Examiner BRIAN P. YENKE Applicant(s)/Patent Under Reexamination KWEON ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-2004/0261108	12-2004	Yuen et al.	725/058
X	В	US-6,807,677	10-2004	Lee, Jae Kyung	725/58
Х	C	US-6,798,420	09-2004	Xie, Xiaodong	345/554
Χ	D	US-6,792,197	09-2004	Helmstetter, Gary	386/83
Χ	E	US-6,411,337	06-2002	Cove et al.	348/563
Χ	F	US-5,990,940	11-1999	Hashimoto et al.	348/184
Χ	G	US-6,179,487	01-2001	Bardon et al.	715/841
Χ	Н	US-6,128,009	10-2000	Ohkura et al.	725/46
	Ι	US-		-	
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			W.		
	0					
	Р					
	σ					
	R			1		
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.